

**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

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1761

**SEARCHED**

Class	Subclass	Date	Examiner
426	632, 655, 481, 482	3/17/2006	AW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	3/17/2006	AW